Application/Control No. Applicant(s)/Patent Under Reexamination 10/009,179 MATSUSHITA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1714 Katarzyna Wyrozebski Lee **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,632,918 10-2003 Matsushita et al. 528/481 Α 10-2000 530/300 В US-6,133,416 Wilson et al. С US-US-D US-Ε F US-G US-USн US- \perp US-Κ US-US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 10-287765 10-1998 Ν JP 06-210633 J٢ Р Q R s Ţ **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Ų W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.